

Notice of References Cited	Application/Control No. 10/526,864		Applicant(s)/Patent Under Reexamination KNAPP ET AL.	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,518,962	02-2003	Kimura et al.	345/211
*	B	US-6,582,980	06-2003	Feldman et al.	438/28
*	C	US-2003/0025718	02-2003	Mori, Makiko	345/690
*	D	US-2003/0016189	01-2003	Abe et al.	345/55
*	E	US-6,593,934	07-2003	Liaw et al.	345/590
*	F	US-2002/0180680	12-2002	Moon, Seung-Hwan	345/89
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 2001305511 A	10-2001	Japan	MURAI et al.	"with ENG trans."
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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